FCC TEST REPORT

For

PHIMAX INTERNATIONAL LIMITED

B1

Model No.: B1

Prepared For : PHIMAX INTERNATIONAL LIMITED

Address : Room 1303, No.95 XinYan Building YanLing Road TianHe Distirct,

Guangzhou, China

Prepared By : Shenzhen Anbotek Compliance Laboratory Limited

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Report Number : SZAWW180830004-01

Date of Receipt : Aug. 30, 2018

Date of Test : Aug. 30~Sept. 17, 2018

Date of Report : Sept. 17, 2018



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Code:AB-RF-05-a



FCC ID: 2AHXM-B1

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TEST REPORT

Applicant PHIMAX INTERNATIONAL LIMITED

Manufacturer PHIMAX INTERNATIONAL LIMITED

Product Name

Model No. B1

Trade Mark N.A

Date of Test

Rating(s) Input: DC 5V, 500mA (with DC 3.7V, 1800mAh Battery inside)

Test Standard(s) FCC Part15 Subpart C 2017, Section 15.247

Test Method(s) ANSI C63.10: 2013

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Aug. 30~Sept. 17, 2018 Prepared by (Engineer / Tangcy Tang) MON Reviewer (Supervisor / Snowy Meng) Approved & Authorized Signer (Manager / Sally Zhang)



1. General Information

1.1. Client Information

Applicant	: PHIMAX INTERNATIONAL LIMITED
Address	Room 1303, No.95 XinYan Building YanLing Road TianHe Distirct, Guangzhou, China
Manufacturer	: PHIMAX INTERNATIONAL LIMITED
Address	Room 1303, No.95 XinYan Building YanLing Road TianHe Distirct, Guangzhou, China
Factory	: PHIMAX INTERNATIONAL LIMITED
Address	Room 1303, No.95 XinYan Building YanLing Road TianHe Distirct, Guangzhou, China

1.2. Description of Device (EUT)

Product Name	:	Blek Anboten Anbo	K Anbotek Anbote Anb hotek A					
Model No.	:	Blotek Anbotek Anb	otek Anbotek Anbotek Am botek					
Trade Mark	:	N.A.	notek Anbotek Anbotek					
Test Power Supply	:	AC 240V, 60Hz for adapter/ AC DC 3.7V Battery inside	20V, 60Hz for adapter/					
Test Sample No.	:	S1(Normal Sample), S2(Engineering Sample)						
		Operation Frequency:	2402MHz~2480MHz					
		Transfer Rate:	1/2/3 Mbits/s					
Product		Number of Channel:	79 Channels					
Description	:	Modulation Type:	GFSK, π/4-DQPSK, 8-DPSK					
		Antenna Type:	PCB Antenna					
		Antenna Gain(Peak):	2 dBi					

Remark: 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

1.3. Auxiliary Equipment Used During Test

r'c	Adapter	:	Manufacturer: ZTE	10'
2			M/N: STC-A2050I1000USBA-C	1
1,			S/N: 201202102100876	P
			Input: 100-240V~ 50/60Hz, 0.3A	
			Output: DC 5V, 1000mA	

1.4. Description of Test Modes

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	etest Mode Description					
Mode 1	CH00					
Mode 2	CH39					
Mode 3	CH78					
Mode 4	Keeping TX+ Charging Mode					

	For Conducted Emission
Final Test Mode	Description
Mode 4	Keeping TX+ Charging Mode

	For Radiated Emission					
Final Test Mode	Description					
Mode 1	K hotek Anbote CH00 And tek obotek A					
Mode 2	CH39					
Mode 3	CH78					
Mode 4	Keeping TX+ Charging Mode					

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
 - (2) The data rate was set in 1Mbps for radiated emission due to the highest RF output power.



T CC ID. ZAITANI

1.5. List of channels

Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.	Channel	Freq.
	(MHz)		(MHz)		(MHz)		(MHz)		(MHz)
00	2402	Anb 17	2419	34	2436	51	2453	68	2470
01	2403	18	2420	35	2437	52	2454	69	2471
02	2404	19	2421	36	2438	53	2455	70	2472
03	2405	20	2422	37	2439	54	2456	71	2473
04	2406	21	2423	38	2440	55	2457	72	2474
05	2407	22	2424	39	2441	56	2458	73	2475
05Amb	2408	23	2425	40	2442	57	2459	74	2476
10 N	2409	24	2426	41 🗥	2443	58	2460	75	2477
08	2410	25	2427	o ^{to 1} 42	2444	59	2461	76 Ant	2478
09	2411	26	2428	43	2445	60	2462	ote ^k 77	2479
An ⁰ 10	2412	27	2429	44	2446	61 _{mb} °	2463	78	2480
phpoto	2413	28	2430	45	2447	62 M	2464	ATT ISK	30018
12,000	2414	29	2431	46	2448	63	2465	1100	
13	2415	30	2432	47	2449	64	2466	ATTO	
14	2416	31	2433	48	2450	65	2467	V din	010
bote 15	2417	32	2434	49	2451	66	2468		
16	2418	33	2435	50	2452	67	2469		

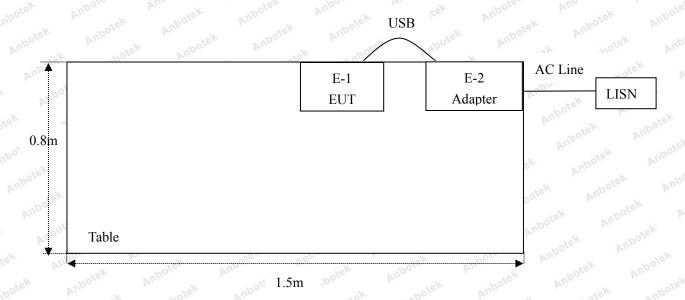
Note:

- 1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
- 2. EUT built-in battery-powered, fully-charged battery use of the test battery.

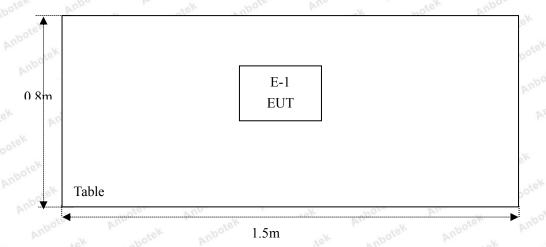


1.6. Description Of Test Setup

CEoo



RE





1.7. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal.
cel ^k .	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Nov. 17, 2017	1 Year
2.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Nov. 17, 2017	1 Year
3.00	RF Switching Unit	Compliance Direction	RSU-M2	38303	Nov. 17, 2017	1 Year
4. px	Spectrum Analysis	Agilent	E4407B	US39390582	Nov. 17, 2017	1 Year
5.	MAX Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year
6.	Preamplifier	SKET Electronic	BK1G18G30D	KD17503	Nov. 17, 2017	1 Year
otek 7.	Double Ridged Horn Antenna	Instruments corporation	GTH-0118	351600	Nov. 20, 2017	1 Year
8.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Nov. 20, 2017	1 Year
9. ^A	Loop Antenna	Schwarzbeck	HFH2-Z2	100047	Nov. 17, 2017	1 Year
10.	Horn Antenna	Schewarzbeck	BBHA9170	9170-375	Nov. 17, 2017	1 Year
11.	Pre-amplifier	SONOMA	310N	186860	Nov. 17, 2017	1 Year
12.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
13.	RF Test Control System	YIHENG	YH3000	2017430	Nov. 18, 2017	1 Year
14.	Power Sensor	DAER	RPR3006W	15I00041SN045	Nov. 17, 2017	1 Year
15.	Power Sensor	DAER	RPR3006W	15I00041SN046	Nov. 17, 2017	1 Year
16.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Nov. 18, 2017	1 Year
17.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Nov. 18, 2017	1 Year
18.	Signal Generator	Agilent	E4421B	MY41000743	Nov. 18, 2017	1 Year
19.	DC Power Supply	LW	TPR-6410D	349315	Nov. 01, 2017	1 Year
20.	Constant Temperature Humidity Chamber	Sertep	ZJ-HWHS80B	ZJ-17042804	Nov. 01, 2017	1 Year



1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registed and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111, July 31, 2017.

ISED-Registration No.: 8058A-1

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A-1, June 13, 2016.

Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

at 1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102



2. Summary of Test Results

Standard Section	Test Item	Result	
15.203/15.247(c)	Antenna Requirement	PASS	
15.207	Conducted Emission	PASS	
15.205/15.209	Spurious Emission	PASS	
15.247(b)(1)	Conducted Peak Output Power	PASS	
15.247(a)(1)	20dB Occupied Bandwidth	PASS	
15.247(a)(1)	Carrier Frequencies Separation	PASS	
15.247(a)(1)	Hopping Channel Number	PASS	
15.247(a)(1)	Dwell Time	PASS	
15.247(d)	Band Edge	PASS	

3. Conducted Emission Test

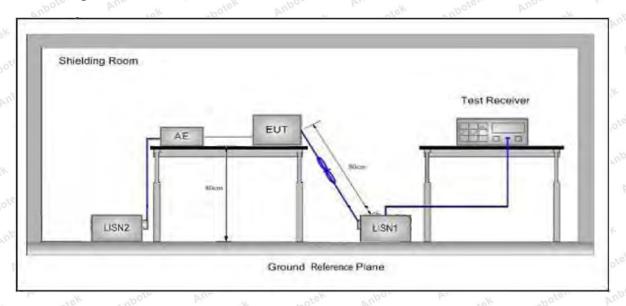
3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.20	07 Anbote Amb	Anbotek Anbo tek			
	F	Maximum RF Line Voltage (dBuV)				
	Frequency	Quasi-peak Level	Average Level			
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *			
4	500kHz~5MHz	Anbotek 56 bot sek	46			
	5MHz~30MHz	60	50			

Remark: (1) *Decreasing linearly with logarithm of the frequency.

(2) The lower limit shall apply at the transition frequency.

3.2. Test Setup



3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10-2013 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

3.4. Test Data

Please to see the following pages

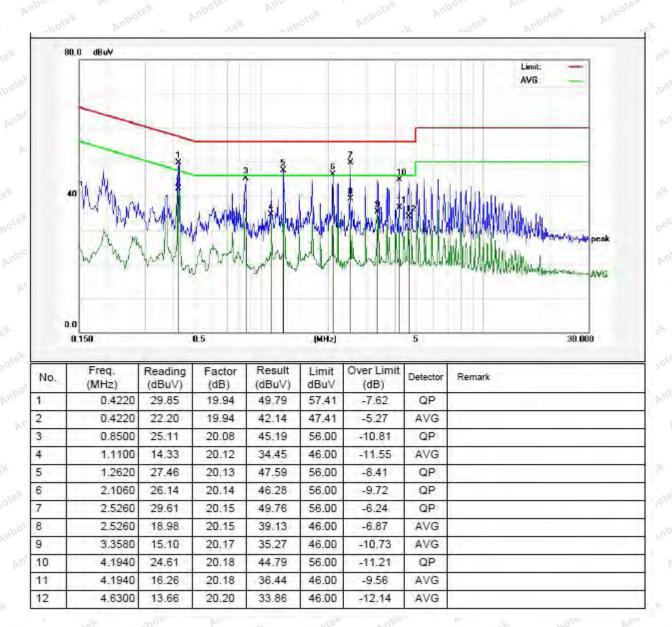


Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line





11

12

3.3900

4.2460

28.10

11.61

20.17

20.19

48.27

31.80

56.00

46.00

-7.73

-14.20

QP

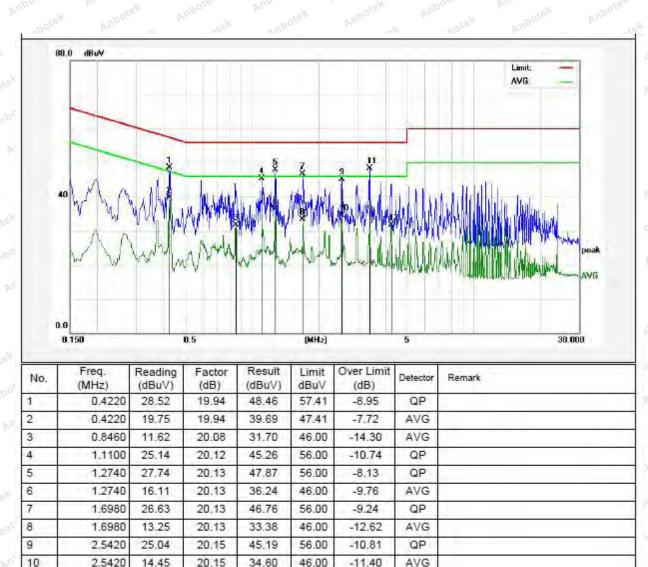
AVG

Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line



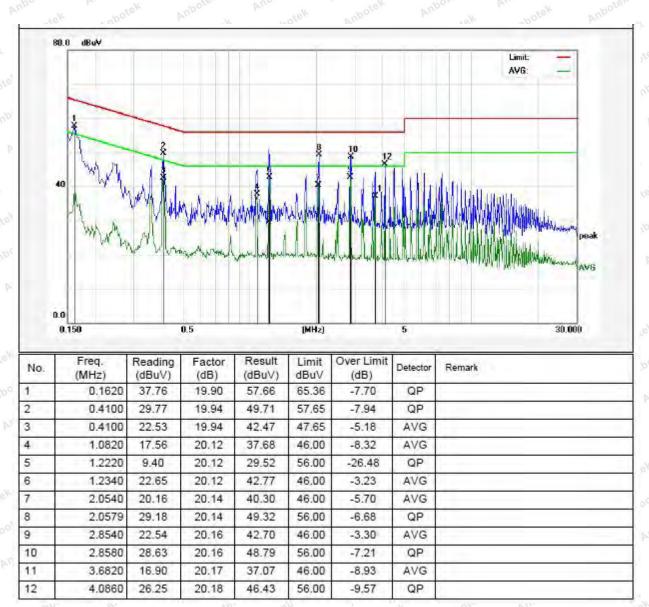


Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Live Line



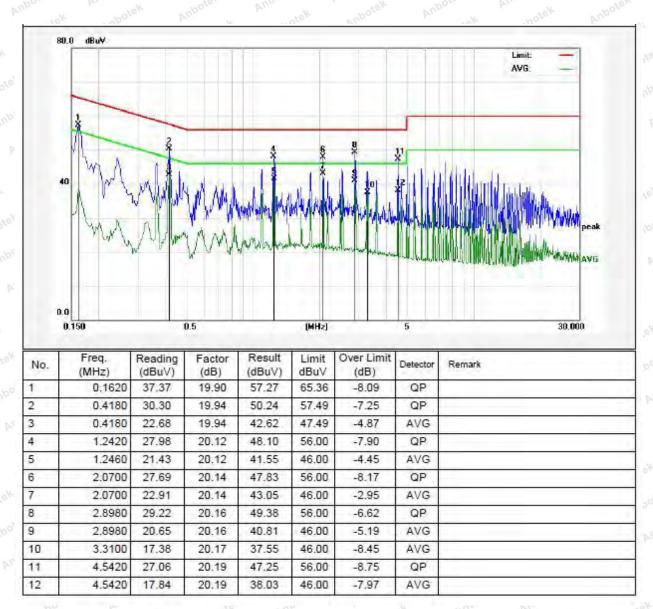


Conducted Emission Test Data

Test Site: 1# Shielded Room

Operating Condition: Keeping TX+ Charging Mode
Test Specification: AC 240V, 60Hz for adapter

Comment: Neutral Line



4. Radiation Spurious Emission and Band Edge

4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.20	09 and 15.205	Am	Anbotek	upo sek
	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
Test Limit	0.009MHz~0.490MHz	2400/F(kHz)	otek - Anbot	ek abote	300
	0.490MHz-1.705MHz	24000/F(kHz)	upotek - Yupe	tek by	30 Anbote
	1.705MHz-30MHz	30	Anbotek A	loo stele	obotek 30 Anb
	30MHz~88MHz	100	40.0	Quasi-peak	Anbote3 A
	88MHz~216MHz	150	43.5	Quasi-peak	3.01
	216MHz~960MHz	200	46.0	Quasi-peak	3 potek
	960MHz~1000MHz	500	54.0	Quasi-peak	tek 3 Anbote
	1000 41	500	54.0	Average	botek 3 Anbr
	Above 1000MHz	Ann hotek	74.0	Peak	anbote 3

Remark:

- (1) The lower limit shall apply at the transition frequency.
- (2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

4.2. Test Setup

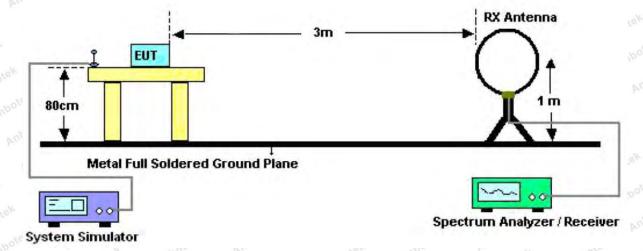


Figure 1. Below 30MHz



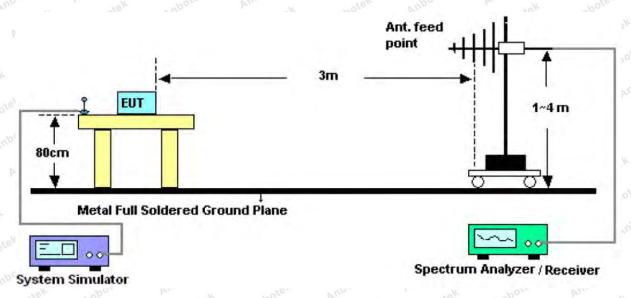


Figure 2. 30MHz to 1GHz

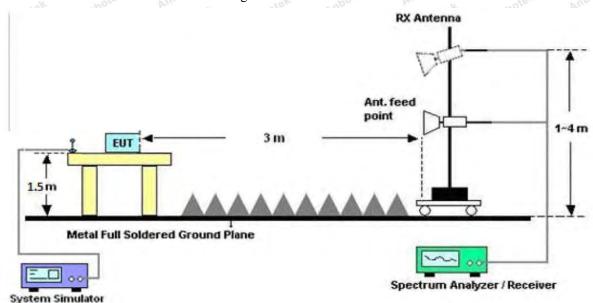


Figure 3. Above 1 GHz

4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9*6*6 Chamber. The device is evaluated in xyz orientation.

For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying



aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW = 1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW = 30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW = 300kHz, Detector = Quasi-Peak, Trace mode = Max hold, Sweep- auto couple.

For above 1GHz, Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

4.4. Test Data

PASS

During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation which is worse case

The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

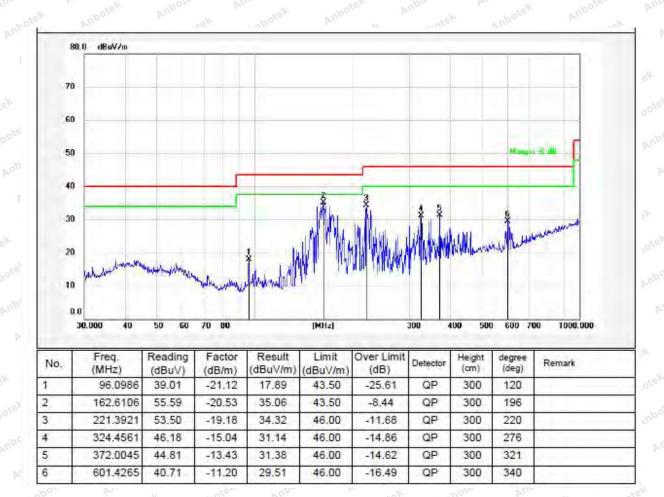


Test Results (30~1000MHz)

Job No.: SZAWW180830004-01 Temp.(°C)/Hum.(%RH): 24.3°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Keeping TX+ Charging Mode Polarization: Horizontal



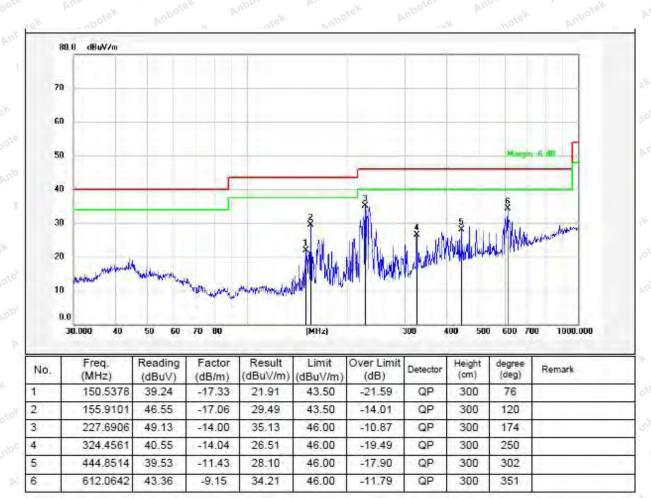


Test Results (30~1000MHz)

Job No.: SZAWW180830004-01 Temp.(°C)/Hum.(%RH): 24.3°C/53.4%RH

Standard: FCC PART 15C Power Source: DC 3.7V Battery inside

Test Mode: Keeping TX+ Charging Mode Polarization: Vertical





FCC ID: 2AHXM-B1

Test Results (1GHz-25GHz)

Test Mode:	CH00			Test	channel: Low	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	36.04	34.04	6.58	34.09	42.57	74.00	-31.43	botek
7206.00	30.99	37.11	7.73	34.50	41.33	74.00	-32.67	AnbV.el
9608.00	30.72	39.31	9.23	34.79	44.47	74.00	-29.53	V
12010.00	*	otek A	upotek b	'upor	anbotek .	74.00	Aup	V
14412.00	*	wotek.	Anbotek	Aupore	An abotek	74.00	Aup	ek V
4804.00	40.07	34.04	6.58	34.09	46.60	74.00	-27.40	H
7206.00	32.63	37.11	7.73	34.50	42.97	74.00	-31.03	Hek
9608.00	30.02	39.31	9.23	34.79	43.77	74.00	-30.23	Anbou
12010.00	*nbote	Aup	Vek V	obotek	Aupore	74.00	Anbotek	PH
14412.00	lek * Anb	Ve. V.	lon lek	anbotek	Anboten	74.00	Anbotek	$H_{V_{\mathcal{C}}}$
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4804.00	25.09	34.04	6.58	34.09	31.62	54.00	-22.38	Voot
7206.00	19.82	37.11	7.73	34.50	30.16	54.00	-23.84	V
9608.00	18.98	39.31	9.23	34.79	32.73	54.00	-21.27	V V
12010.00	poter * A	loo tek	abotek	Anboter	k kote	54.00	Aupo	V
14412.00	Mupote *	Anbo	A hotek	Anboli	K MUD	54.00	tek An	V
4804.00	29.18	34.04	6.58	34.09	35.71	54.00	-18.29	Anbole H
7206.00	21.91	37.11	7.73	34.50	32.25	54.00	-21.75	PH
9608.00	18.60	39.31	9.23	34.79	32.35	54.00	-21.65	\mathbf{H}^{u_l}
12010.00	otek * Ar	potek	Aupor	An abotek	Anbotek	54.00	anbote	Н
14412.00	*	anbotek	Anbore	An note	k Anbote	54.00	iek "A	ote ^K H



Test Results (1GHz-25GHz)

Test Mode:	CH39			Test	channel: Mid	dle		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	36.08	34.38	6.69	34.09	43.06	74.00	-30.94	boteV
7323.00	31.02	37.22	7.78	34.53	41.49	74.00	-32.51	AnbVel
9764.00	30.74	39.46	9.35	34.80	44.75	74.00	-29.25	V
12205.00	*	otek p	upotek P	'upor	An abotek	74.00	Vup.	V
14646.00	*	wotek.	Anbotek	Anbote	An potek	74.00	Anb	ek V
4882.00	40.12	34.38	6.69	34.09	47.10	74.00	-26.90	H
7323.00	32.66	37.22	7.78	34.53	43.13	74.00	-30.87	H
9764.00	30.05	39.46	9.35	34.80	44.06	74.00	-29.94	Aupo.
12205.00	* Anbote	Vup.	stek.	abotek	Aupore	74.00	Anbotek	H
14646.00	lek * Anb	Step V.	log b	upotek	Anbote	74.00	Anbotek	ΗÞ
			A	verage Value	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4882.00	25.13	34.38	6.69	34.09	32.11	54.00	-21.89	V
7323.00	19.85	37.22	7.78	34.53	30.32	54.00	-23.68	V
9764.00	19.00	39.46	9.35	34.80	33.01	54.00	-20.99	V
12205.00	00 ^{tet} * A	ipo rek	Anbotek	Anboten	k hote	54.00	Anbo	V
14646.00	Anbote*	Aupo	Abotek	Aupore	K VUD	54.00	tek An	V
4882.00	29.23	34.38	6.69	34.09	36.21	54.00	-17.79	Aupore H
7323.00	21.94	37.22	7.78	34.53	32.41	54.00	-21.59	PH
9764.00	18.63	39.46	9.35	34.80	32.64	54.00	-21.36	H
12205.00	otek *	potek	Aupor	A botek	Anbotek	54.00	Anbote	Н
14646.00	*	anbotek	Aupor	Por Porte	k Anbote	54.00	10 10	ote ^K H



Test Results (1GHz-25GHz)

Test Mode: 0	CH78			Test	channel: Highe	est		
				Peak Value				
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	35.88	34.72	6.79	34.09	43.30	74.00	-30.70	boteV
7440.00	30.89	37.34	7.82	34.57	41.48	74.00	-32.52	No Vel
9920.00	30.63	39.62	9.46	34.81	44.90	74.00	-29.10	V
12400.00	*	stek	abotek p	upor	Vu.	74.00	Anbo	V
14880.00	* 400	ntek	nbotek	Anbotek	Yu.,	74.00	Aupor	V
4960.00	39.88	34.72	6.79	34.09	47.30	74.00	-26.70	H
7440.00	32.52	37.34	7.82	34.57	43.11	74.00	-30.89	H'A
9920.00	29.92	39.62	9.46	34.81	44.19	74.00	-29.81	Aupor
12400.00	* nbote	Anbo	18K	botek	Anbotek	74.00	anbotek	PH
14880.00	lek * Anbr	Vek by	loor b	"polek	Anborek	74.00	Napotek	HΑ
			A	verage Valu	e			
Frequency (MHz)	Read Level (dBuV)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Factor (dB)	Level (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Pol.
4960.00	25.01	34.72	6.79	34.09	32.43	54.00	-21.57	V
7440.00	19.76	37.34	7.82	34.57	30.35	54.00	-23.65	V
9920.00	18.92	39.62	9.46	34.81	33.19	54.00	-20.81	V
12400.00	potek * Ar	lpor.	hotek.	Anbotes	Anbo	54.00	Anbo	V
14880.00	*	Anbore	hotek	Anboli	Amb	54.00	cek An	V
4960.00	29.08	34.72	6.79	34.09	36.50	54.00	-17.50	Aupoter.
7440.00	21.84	37.34	7.82	34.57	32.43	54.00	-21.57	ÞĤ
9920.00	18.54	39.62	9.46	34.81	32.81	54.00	-21.19	Hari
12400.00	*	potek	Aupore	And	Anbotek	54.00	A.v.	Н
14880.00	*	abotek	Aupole	Aug.	k Anbote	54.00	ok k	o ^{tel} H

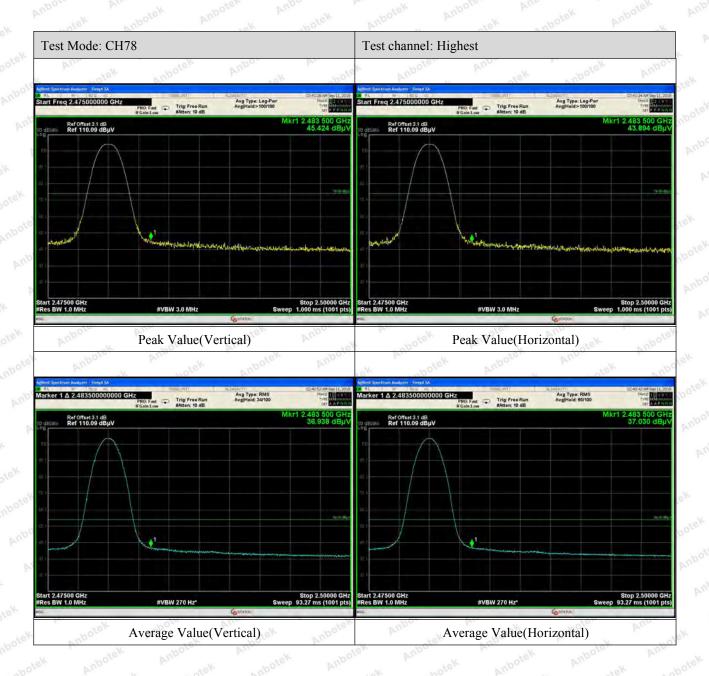
Remark

- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level =Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor
- 3. "*" means the test results were attenuated more than 20dB below the permissible limits, so the results don't record in the report.

Radiated Band Edge:







Remark:

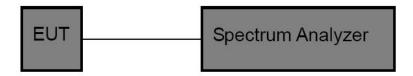
- 1. During the test, pre-scan the GFSK, $\pi/4$ QPSK, 8DPSK modulation, and found the GFSK modulation is worse case, the report only record this mode.
- 2. Level = Receiver Read level + Antenna Factor + Cable Loss Preamplifier Factor

5. Maximum Peak Output Power Test

5.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.2	247 (b)(3)	Ann	Anbotek	Anbore	VI.
Test Limit	1W or 125 mW	Anbote.	Anv	Anbotek	Anbor	7

5.2. Test Setup



5.3. Test Procedure

- 1. The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
- 2. Spectrum Setting:

RBW > the 20 dB bandwidth of the emission being measured

Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel

 $VBW \ge RBW$

Sweep = auto

Detector function = peak

Trace = \max hold

5.4. Test Data

Test Item	:	Max. peak output power	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	23.6℃
Test Result	:	PASS	Humidity	:	56%RH

Limit (dBm)	Results	Modulation
30	PASS	BDR BDR
30	PASS	BDR
30 30 Notek	PASS	BDR
20.96	PASS	EDR
20.96	PASS	EDR
20.96	PASS	EDR
16	20.96	20.96 PASS

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of (8DPSK) is attached in the following pages.



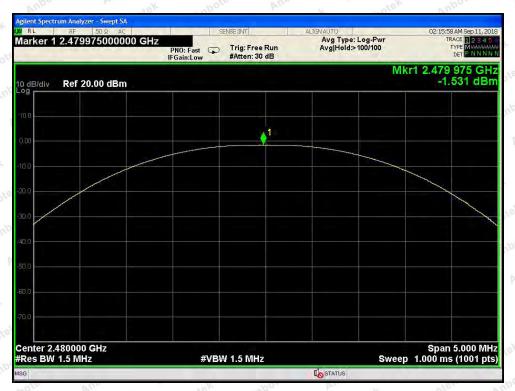


Test Mode: BDR---Low



Test Mode: BDR---Middle



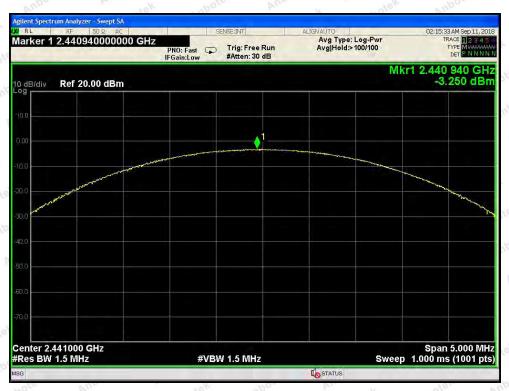


Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



Test Mode: EDR---High

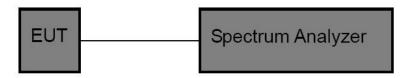


6. 20DB Occupy Bandwidth Test

6.1. Test Standard

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Ann	Anbotek	Anbo	p.
---------------	------------------------------------	-----	---------	------	----

6.2. Test Setup



6.3. Test Procedure

Using the following spectrum analyzer settings:

- 1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

6.4. Test Data

	Test Item :	20dB BW	Test Mode	:	CH Low ~ CH High
--	-------------	---------	-----------	---	------------------

Test Voltage : DC 3.7V Battery inside Temperature : 23.6° C Test Result : PASS Humidity : 56° RH

	Y 14	VII.	No.	16.
o ^t	Channel	Frequency(MHz)	20dB Down BW(kHz)	Modulation Mode
nbote	Low	2402	828.6	BDR
, ant	Middle	2441	825.4	BDR
	High	2480	744.3	BDR
	Low	2402	1266.0	EDR
tek.	Middle	2441	1263.0	EDR
note	High	2480	1267.0	EDR

Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of (8DPSK) is attached in the following pages.





Test Mode: BDR---Low



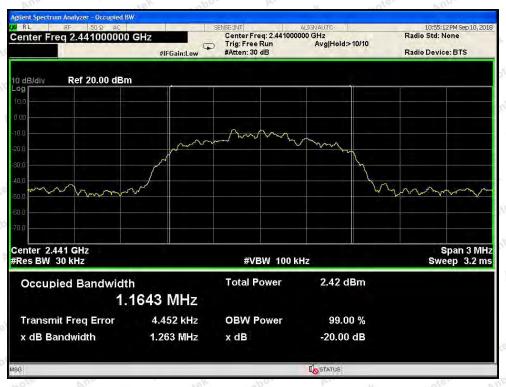
Test Mode: BDR---Middle



Test Mode: BDR---High



Test Mode: EDR---Low



Test Mode: EDR---Middle



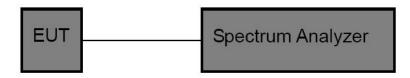
Test Mode: EDR---High

7. Carrier Frequency Separation Test

7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)	Anbotek	Anbo stek
Test Limit	>25KHz or >two-thirds of the 20 dB bandwidth	Anbotek	Anbo

7.2. Test Setup



7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

- 1. Span= Wide enough to capture the peaks of two adjacent channels
- 2. Set the RBW = 30 kHz.
- 3. Set the VBW = 100 kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

7.4. Test Data

Test Item	:	Frequency Separation	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 3.7V Battery inside	Temperature	:	23.6°C
Test Result	:	PASS	Humidity	:	56%RH

Channel	Frequency	Separation Read	Limit	Modulation Mode
	(MHz)	Value (kHz)	(kHz)	Modulation Mode
Low	2402	1000	828.6	BDR
Middle	2441	1000	825.4	BDR
High	2480	1000	744.3	BDR Anbot
Low	2402	1000	844.0	Anbote EDR Anbo
Middle	2441	1000	842.0	EDR
High	2480	1000	844.7	EDR

Remark:

- 1. The limit of mode (EDR) is 2/3 of 20dB BW;
- 2. The EDR was tested on (π /4DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.





Test Mode: BDR---Low



Test Mode: BDR---Middle





Test Mode: BDR---High



Test Mode: EDR---Low





Test Mode: EDR---Middle



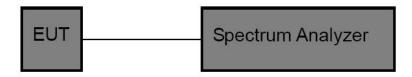
Test Mode: EDR---High

8. Number of Hopping Channel Test

8.1. Test Standard and Limit

Test Standard	FCC Part15 C	Section 15.2	247 (a)(1)	Annabotek	Anbotek	Anbo	200
Test Limit	>15 channels	Anbotek	Anboro	An	Anbotek	Anbo	1

8.2. Test Setup



8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

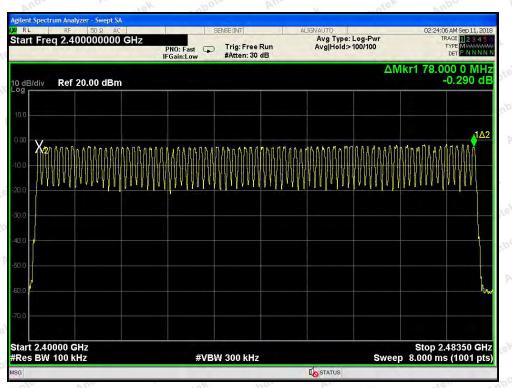
- 1. Span= the frequency band of operation
- 2. Set the RBW = 100kHz.
- 3. Set the VBW = 300kHz.
- 4. Sweep time = auto couple.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

8.4. Test Data

Test Item	: Number of Hopping Frequency	Test Mode :	CH Low ~ CH High
Test Voltage	: DC 3.7V Battery inside	Temperature :	23.6℃
Test Result	: PASS	Humidity :	56%RH

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel
2402-2480MHz	And tak 79 botek Anbot	>15 mboten





BDR Mode



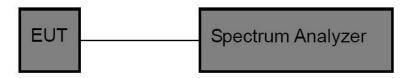
EDR Mode

9. Dwell Time Test

9.1. Test Standard and Limit

Test Standard	FCC Part15	C Section 15.2	47 (a)(1)	Ambotek	Anbotek	Anbo	b.
Test Limit	0.4 sec	Anbotek	Anboro	Arr.	Anbotek	Anbo	F .

9.2. Test Setup



9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

- 1. Span= zero span, centered on a hopping channel
- 2. Set the RBW = 1 MHz.
- 3. Set the VBW = 1 MHz.
- 4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
- 5. Detector function = peak.
- 6. Trace mode = max hold.
- 7. Allow trace to fully stabilize.

9.4. Test Data

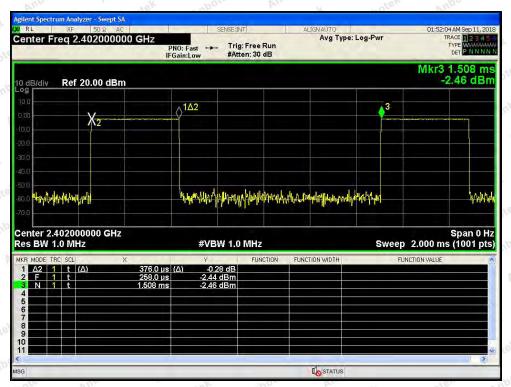
Test Item : Time of Occupancy Test Mode : CH Low ~ CH High

Test Voltage : DC 3.7V Battery inside Temperature : 23.6° C Test Result : PASS Humidity : 56° RH

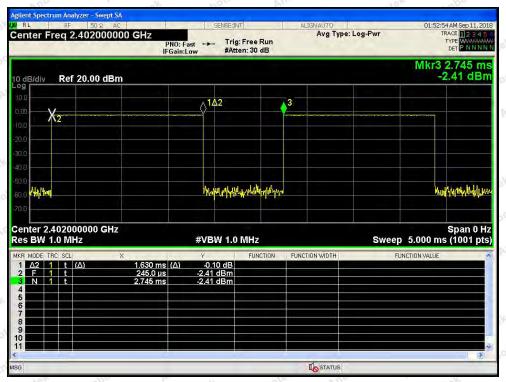
Package Type	Pulse width (ms)	Time slot length(ms)	Dwell time (ms)	Limit (s)	Modulation
DH1	0.376	time slot length *1600/2 /79 * 31.6	120.32	0.4	BDR
DH3	1.630	time slot length *1600/4 /79 * 31.6	260.80	0.4	BDR
DH5	2.880	time slot length *1600/6 /79 * 31.6	307.20	0.4	BDR
3DH1	0.382	time slot length *1600/2 /79 * 31.6	122.24	0.4	EDR
3DH3	1.630	time slot length *1600/4 /79 * 31.6	260.80	0.4	EDR
3DH5	2.888	time slot length *1600/6 /79 * 31.6	308.05	0.4	EDR

Remark: The EDR was tested on ($\pi/4$ DQPSK, 8DPSK) modes, only the worst data of (8DPSK) is attached in the following pages.



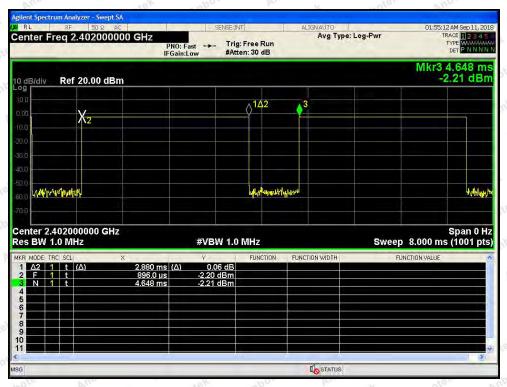


Test Mode: BDR---DH1

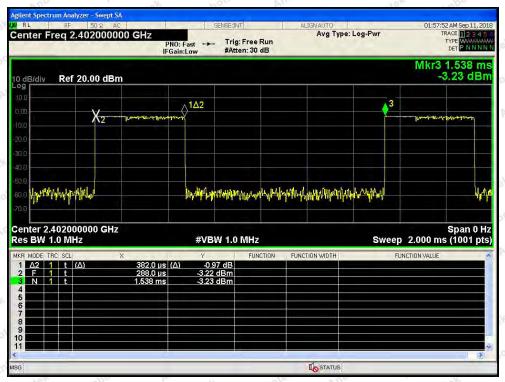


Test Mode: BDR---DH3



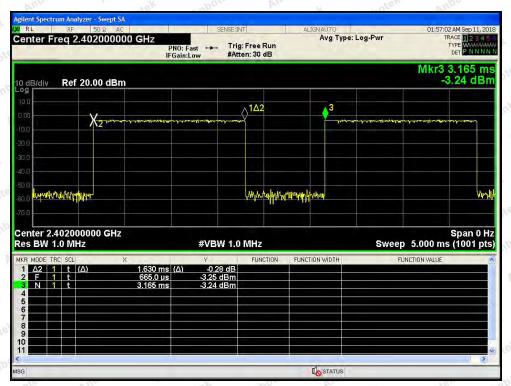


Test Mode: BDR—DH5

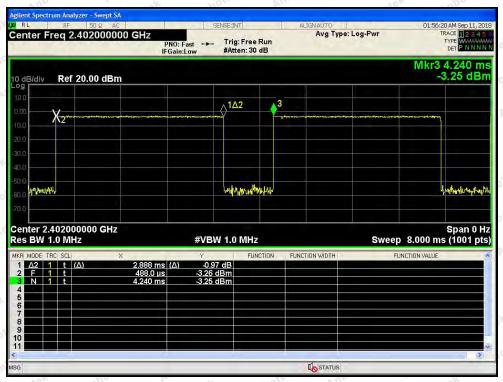


Test Mode: EDR---3DH1





Test Mode: EDR---3DH3



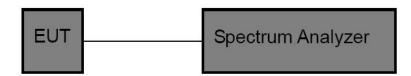
Test Mode: EDR—3DH5

10. 100kHz Bandwidth of Frequency Band Edge Requirement

10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator in operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

10.2. Test Setup



10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

- 1. Set the RBW = 100kHz.
- 2. Set the VBW = 300kHz.
- 3. Sweep time = auto couple.
- 4. Detector function = peak.
- 5. Trace mode = \max hold.
- 6. Allow trace to fully stabilize.

10.4. Test Data

 Test Item
 : Band edge
 Test Mode
 : CH Low ~ CH High

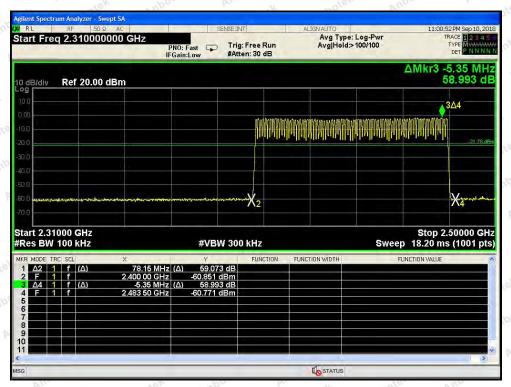
 Test Voltage
 : DC 3.7V Battery inside
 Temperature
 : 23.6 ℃

 Test Result
 : PASS
 Humidity
 : 56%RH

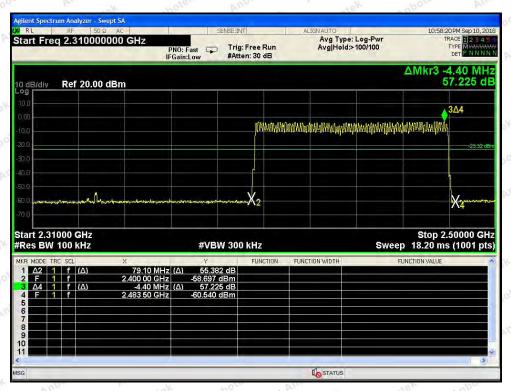
Remark: The EDR was tested on $(\pi/4DQPSK, 8DPSK)$ modes, only the worst data of $(\pi/4DQPSK)$ is attached in the following pages.



For Hopping Mode



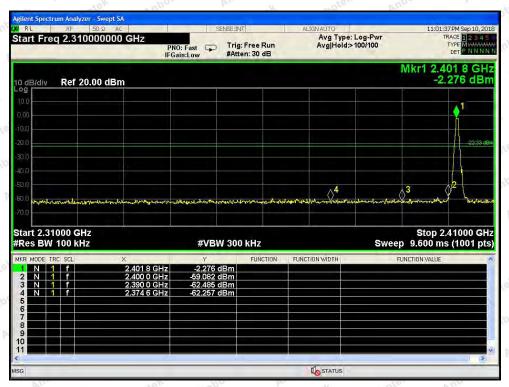
BDR mode



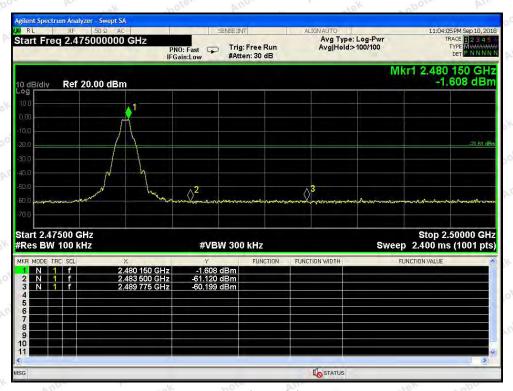
EDR mode



For Non-Hopping Mode

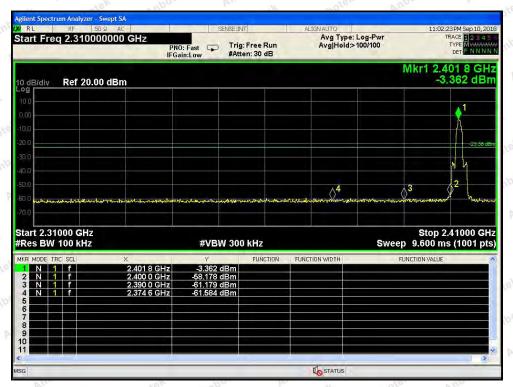


BDR mode -- Lowest

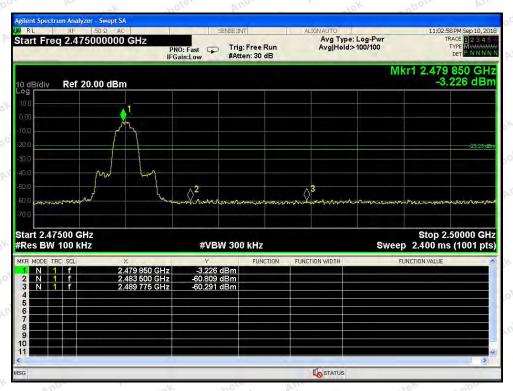


BDR mode -- Highest

For Non-Hopping Mode

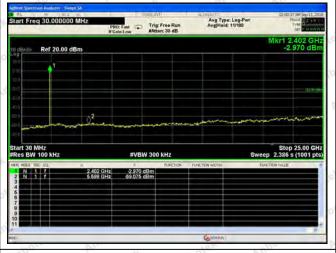


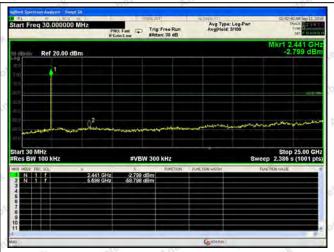
EDR mode -- Lowest



EDR mode -- Highest

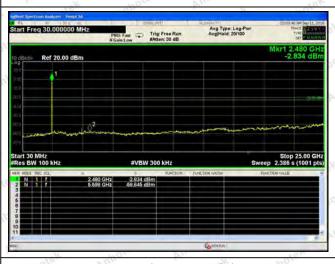
Conducted Emission Method

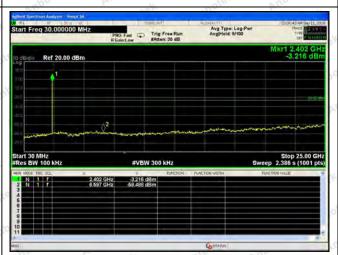




Test Mode: BDR---Low

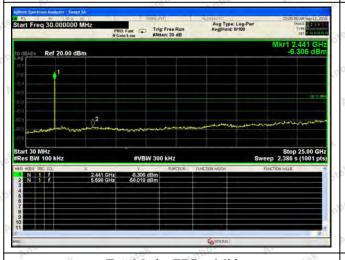
Test Mode: BDR---Mid

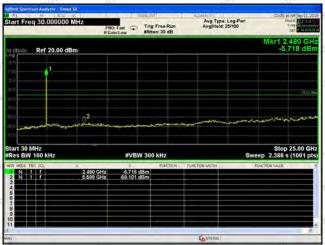




Test Mode: BDR---High

Test Mode: EDR---Low





Test Mode: EDR---Mid

Test Mode: EDR---High

11. Antenna Requirement

11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
	1) 15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished
	by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but
Requirement	the use of a standard antenna jack or electrical connector is prohibited. 2) 15.247(c) (1)(i) requirement:
	Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed Point-to-point operations may employ transmitting antennas with directional gain greate than 6dBi provided the maximum conducted output power of the intentional radiator is reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.

11.2. Antenna Connected Construction

The bluetooth antenna is PCB Antenna which permanently attached, and the best case gain of the antenna is 2 dBi. It complies with the standard requirement.



APPENDIX I -- TEST SETUP PHOTOGRAPH

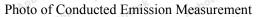




Photo of Radiation Emission Test







APPENDIX II -- EXTERNAL PHOTOGRAPH



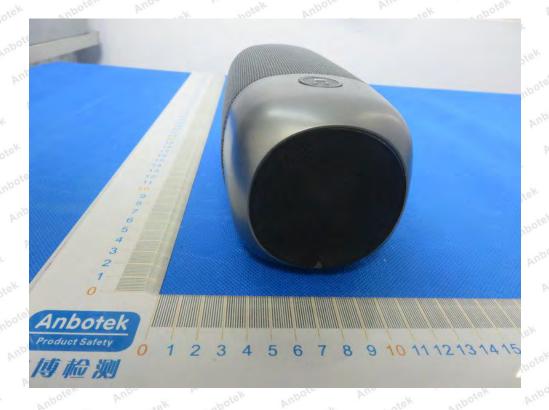
















APPENDIX III -- INTERNAL PHOTOGRAPH















-- End of Report --